



Supervised machine learning

An introduction



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Outline

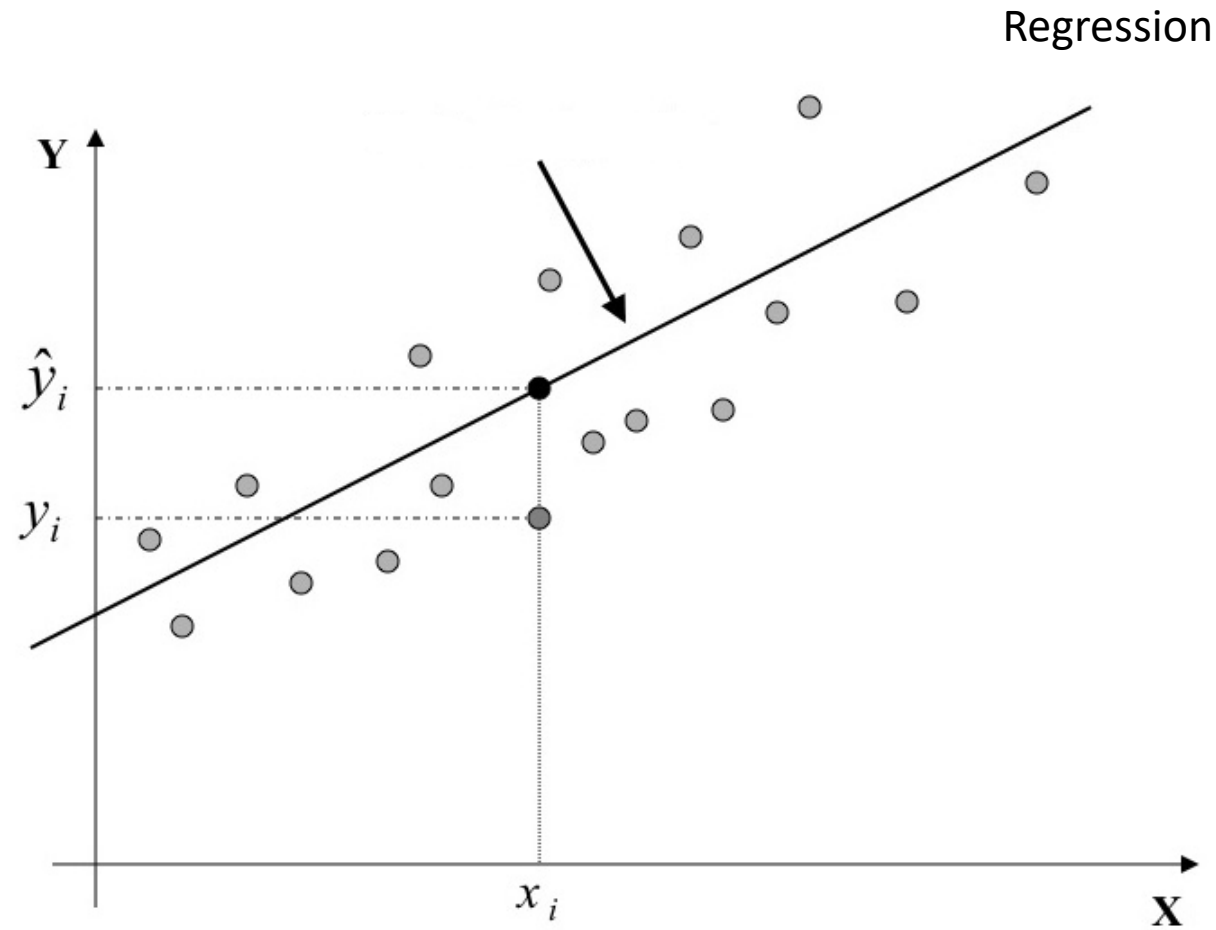
1. Recall

- Supervised/Re-inforcement/Unsupervised
- Generative/Discriminative models
- Fitting probability models
- Fitting discriminative models
- Fitting generative models

Recall

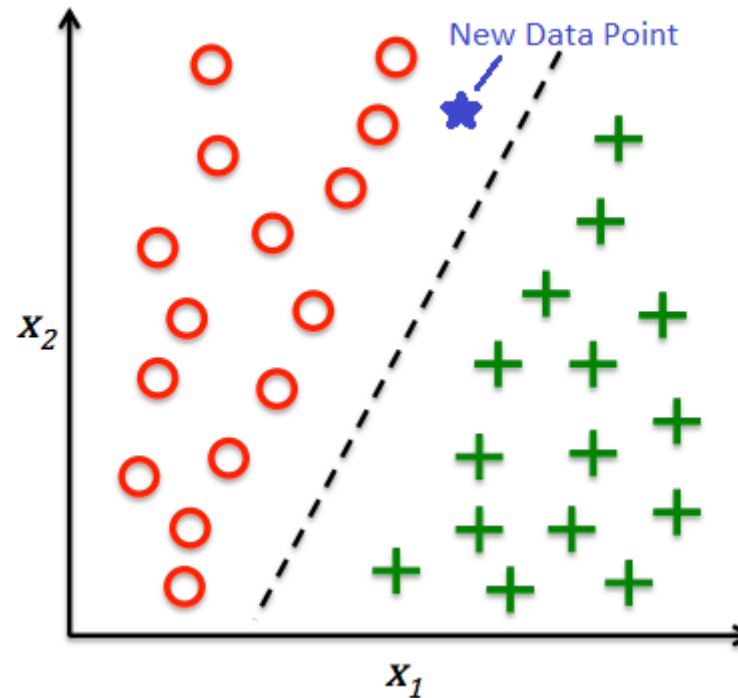
- Supervised learning
 - task of learning a function: f
 - that maps an input to an output : $f: X \rightarrow Y$
 - based on example input-output pairs : $\{x_i, y_i\}_{i=1}^N$; $x_i \in X$ et $y_i \in Y$
- Reinforcement learning $f = f_1 \circ f_{\dots} \circ f_k: X \rightarrow \bar{Y}$
 - differs from supervised learning
 - f is composed of sub functions (in X) to output \bar{y}_i ,
 - Incomplete feedback (\bar{y}_i is not completely given $\bar{y}_i \subset y_i \in Y$)
- Unsupervised learning
 - task of learning a function: f
 - that maps an input to an output : $f: X \rightarrow Z$
 - based on input examples : $\{x_i\}_{i=1}^N$; $x_i \in X$
 - No labels (y_i) are given

Recall : Supervised learning



Recall : Supervised learning

Classification



Credit : <https://towardsdatascience.com/supervised-learning-basics-of-classification-and-main-algorithms-c16b06806cd3>

Recall : Supervised learning

- Regression : $f: X \rightarrow Y$ and $y \in \mathbb{R}$
- Classification : $f: X \rightarrow Y$ and $y \in \{a, b, c, d\}$
- Structured classification : $f: X \rightarrow Y$ and $y \in \{a, b, c, d\}^{N \times M}$
- Structured Regression : $f: X \rightarrow Y$ and $y \in \mathbb{R}^{N \times M}$
- Structured Regression : $f: X \rightarrow Y$ and $y \in \mathbf{G}$ (*graph space*)
- Structured learning when the output is complex:
 - Segmentation mask for instance

Recall : Probability = rational way to deal with uncertainty

$\Pr(X,Y)$ = joint probability

$\Pr(Y|X)$ = conditional probability

$\Pr(X)$ = Marginal probability

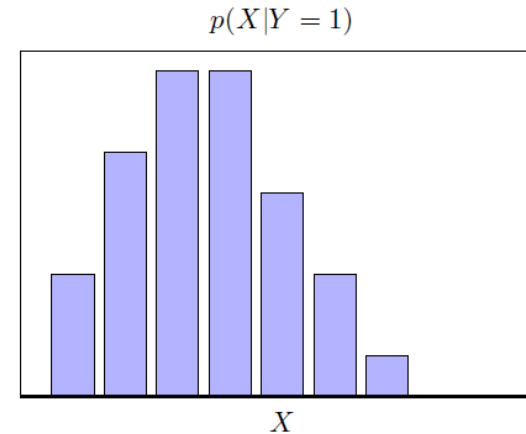
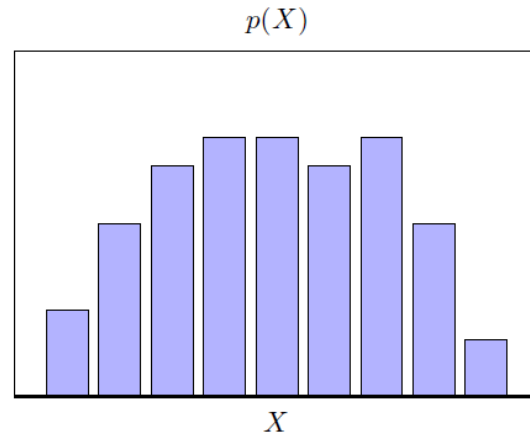
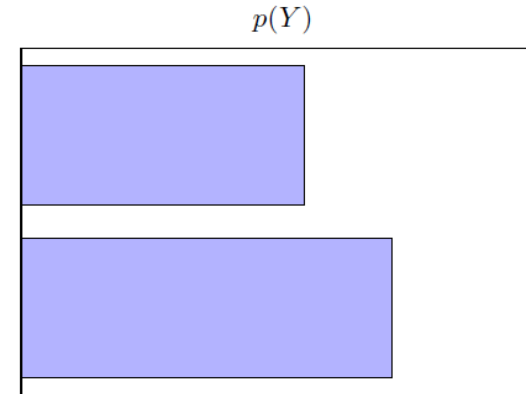
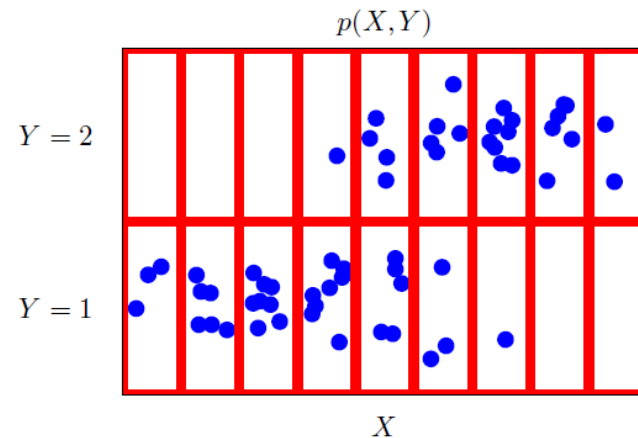
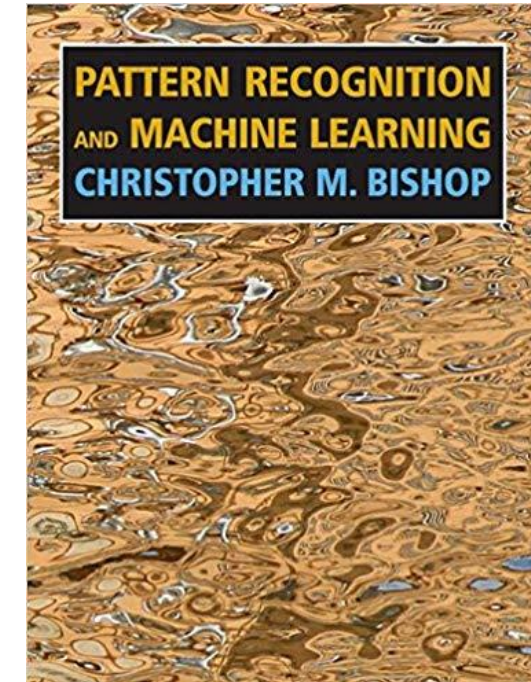


Image taken from



Recall : The Rules of Probability

sum rule $p(X) = \sum_Y p(X, Y)$ → called Marginalization

product rule $p(X, Y) = p(Y|X)p(X).$

Recall : Bayes' rule : provide a quantification of uncertainty

$$p(X, Y) = p(Y, X), \quad \rightarrow \text{Symmetry}$$

$$p(Y|X) = \frac{p(X|Y)p(Y)}{p(X)}$$

$$p(X) = \sum_Y p(X|Y)p(Y)$$

Recall : Supervised learning

- **Discriminative and Generative models**

Models relating the data x to the target y fall into one of two categories. We either:

1. model the contingency of the target state on the data $Pr(y|x)$ or
2. model the contingency of the data on the world state $Pr(x|y)$.

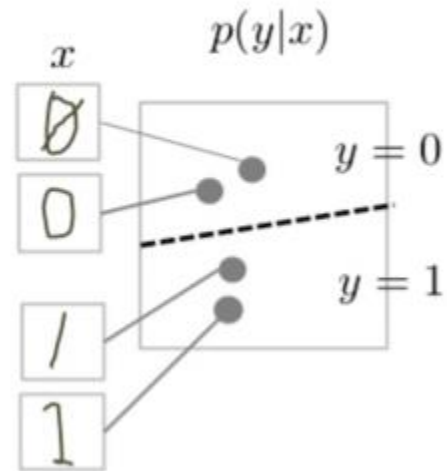
The first type of model is termed discriminative. The second is termed generative;

The target y can be a class label ("cat") if we are dealing with a classification problem.

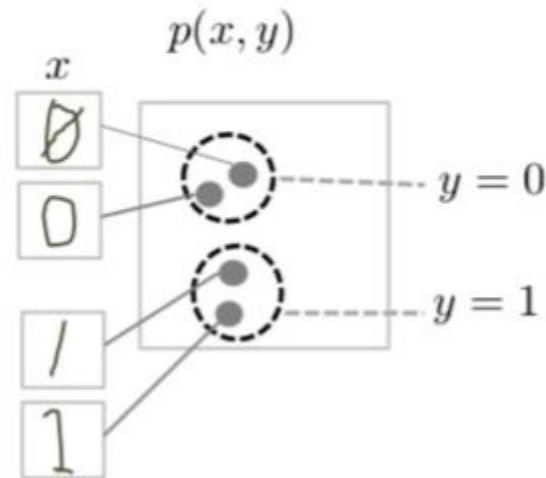
or just $Pr(x)$: if there are no output labels [this is a generative model]

Recall : Supervised learning

- Discriminative Model



- Generative Model



Credit:

https://developers.google.com/machine-learning/gan/images/generative_v_discriminative.png

Recall: Supervised learning : What can we learn?

We want to find these distributions:

- $\Pr(y|x)$ or
- $\Pr(x|y)$

Where can we act?

1. On the parameters of the distributions.
2. Let's call them W

Parametrized distributions are :

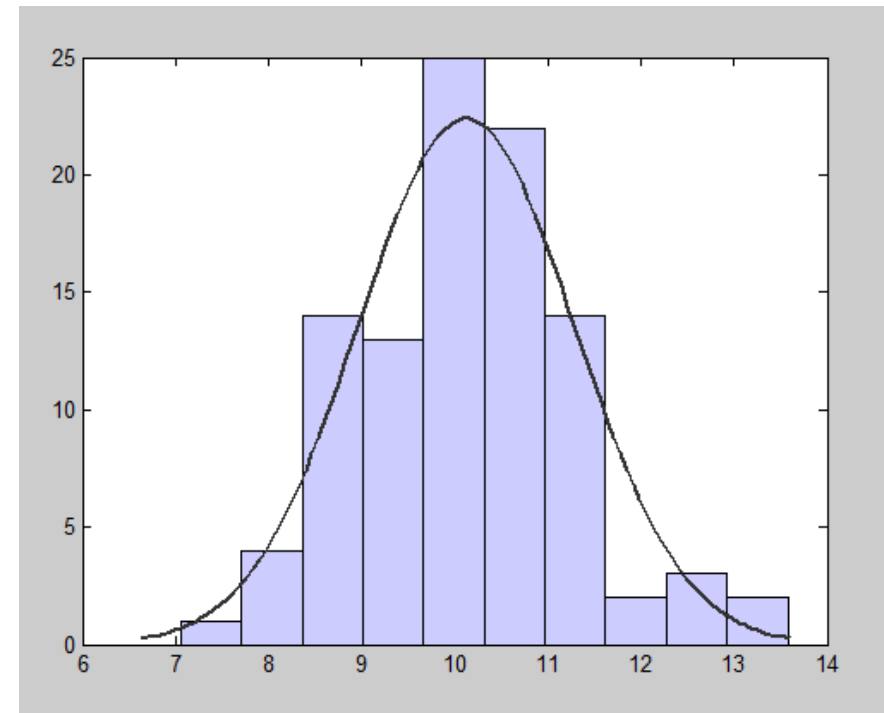
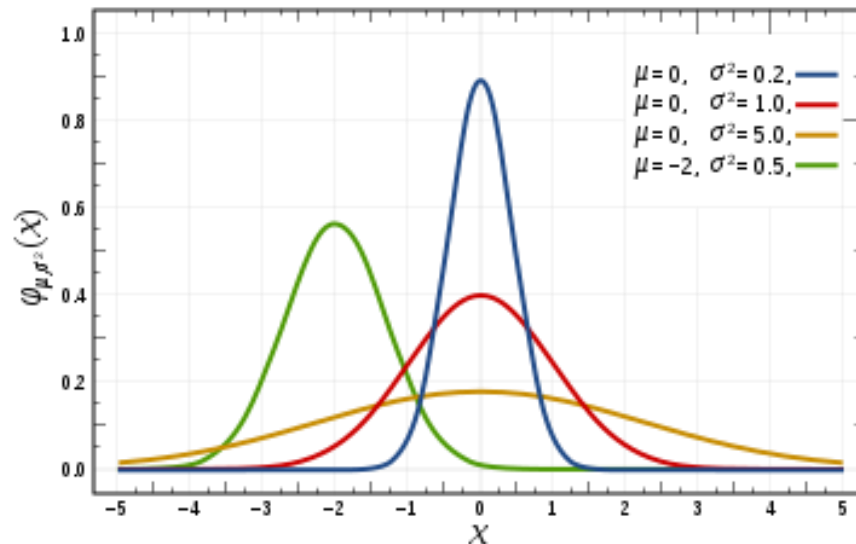
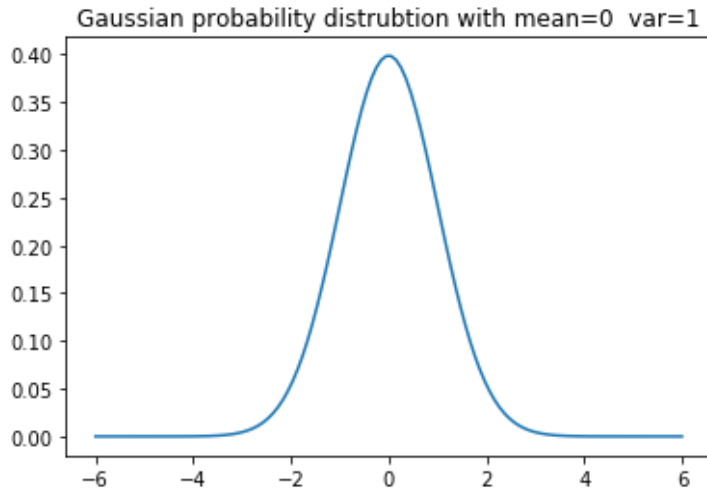
- $\Pr(y|x,W)$ or
- $\Pr(x|y,W)$

Recall: Supervised learning : fitting probability models

We want to find the parameters (W) such that the probability distribution fits the data

Recall: Supervised learning : fitting probability models

$$Pr(x|\mu, \sigma^2) = \frac{1}{\sqrt{2\pi\sigma^2}} \exp\left\{-\frac{(x - \mu)^2}{2\sigma^2}\right\} = \mathcal{N}(x|\mu, \sigma^2)$$



Recall: Supervised learning : fitting probability models

- We find the parameters to fit the data
- Three main ways :
 - 1°) Maximum likelihood

$$W^* = \arg \max_W [Pr(x_1, \dots, x_M | W)]$$

$$W^* = \arg \max_W \left[\prod_{i=1}^M Pr(x_i | W) \right]$$

- Assuming each data point was drawn independently from the distribution (i.i.d)

Recall: Supervised learning : fitting probability models

- Three ways :

- 2°) Maximum a posteriori

$$W^* = \arg \max_W \left[Pr(W|x_1, \dots, x_M) \right]$$

$$W^* = \arg \max_W \left[\frac{Pr(x_1, \dots, x_M|W).Pr(W)}{Pr(x_1, \dots, x_M)} \right]$$

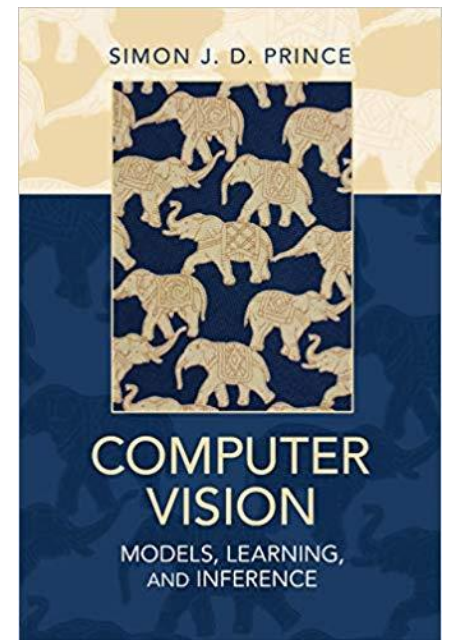
$$W^* = \arg \max_W \left[\frac{\prod_{i=1}^M Pr(x_i|W).Pr(W)}{Pr(x_1, \dots, x_M)} \right]$$

$$W^* = \arg \max_W \left[\prod_{i=1}^M Pr(x_i|W).Pr(W) \right]$$

- Assuming each data point was drawn independently from the distribution (i.i.d)

Recall: Supervised learning : fitting probability models

- Three ways :
 - 3°) The Bayesian approach $Pr(W|x_1, \dots, x_M)$
 - Beyond the scope of this lecture



A nice book

Recall : Supervised learning : fitting probability models : On a Gaussian

- Fitting by Maximum of likelihood:

$$\hat{\mu} = \frac{1}{N} \sum_{i=1}^N x_i \quad \hat{\sigma}^2 = \frac{1}{N} \sum_{i=1}^N (x_i - \hat{\mu})^2$$

- Overfitting phenomenon of the maximum likelihood
 - <http://romain.raveaux.free.fr/document/Overfittingbiasedandunbiasedvariance.html>
- Fitting by Maximum a posteriori: $W=[\text{mean}, \text{variance}]$
 - Well it depends on the prior ($\Pr(W)$)
 - See conjugate distribution
 - the result is proportional to a new distribution which has the same form as the conjugate.
 - Non informative prior

Recall: Learning a discriminative model

$$\mathcal{D} = \{x_i, y_i\}_{i=1}^M$$

- A discriminative model :
 $\Pr(y|x)$
- A discriminative model
with its parameters:
 $\Pr(y|x, W)$
- Maximum of likelihood:
That's what your favorite
standard neural network
does

$$W^* = \arg \max_W \left[\prod_{i=1}^M \Pr(y_i|x_i; W) \right]$$

Link to : **Minimizing the cross entropy : a nice trip from Maximum likelihood to Kullback–Leibler divergence**

<http://romain.raveaux.free.fr/document/CrossEntropy.html>

Recall Learning a discriminative model

- A discriminative model :
 $\Pr(y|x)$
- A discriminative model
with its parameters:
 $\Pr(y|x,W)$
- Maximum a posteriori
(MAP)
 - Your favorite neural
network can do that if you
precise some strcuture on
 $\Pr(W)$

$$\mathcal{D} = \{x_i, y_i\}_{i=1}^M$$

$$W^* = \arg \max_W \left[\Pr(W|y_1, \dots, y_M; x_1, \dots, x_M) \right]$$

$$W^* = \arg \max_W \left[\Pr(W|\mathcal{D}) \right]$$

$$W^* = \arg \max_W \left[\frac{\Pr(\mathcal{D}|W).Pr(W)}{\Pr(\mathcal{D})} \right]$$

$$W^* = \arg \max_W \left[\Pr(\mathcal{D}|W).Pr(W) \right]$$

$$W^* = \arg \max_W \left[\Pr(y_1, \dots, y_M|x_1, \dots, x_M; W).Pr(W) \right]$$

$$W^* = \arg \max_W \left[\prod_{i=1}^M \Pr(y_i|x_i; W).Pr(W) \right]$$

Link to : **Minimizing the least squares error with quadratic regularization**

<http://romain.raveaux.free.fr/document/LeastSquaresError.html>

Recall: Learning a generative model

- A generative model :
 $\Pr(x|y)$
- A generative model with its parameters: $\Pr(x|y,W)$
- Maximum of likelihood
 - That's what a Generative Adversarial Network (GAN) does
- Can be used for classification:
 - See Naive Bayes classifier

$$W^* = \arg \max_W \left[\prod_{i=1}^M \Pr(x_i|y_i; W) \right]$$

<http://romain.raveaux.free.fr/document/NaiveBayesClassifier.html>

Recall: Learning a generative model

- A generative model :
 $\Pr(x|y)$
- A generative model with
its parameters: $\Pr(x|y,W)$
- Maximum of a posteriori

$$W^* = \arg \max_W \left[\prod_{i=1}^M \Pr(x_i|y_i; W) \cdot \Pr(W) \right]$$

Recall : summary

Why is everything an optimization problem?

Why all the formulas?

Why not simply teach algorithms?

Because...

- we want to separate between:
 - ▶ what is our ideal goal?
= **objective function**
 - ▶ (how) do we achieve it?
= **optimization method**
- defining a goal helps in **understanding** the problem
- mathematical formulation allows **re-using existing algorithms** (developed for different tasks)

